FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 03500.014323.1		APPLICATION NO.  NOT YET ASSIGNED						
			APPLICANT  NOBUHIRO ITO ET AL.								
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			U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE					
KQ	6,441,544	8/02	Ando et al.	313	310	6/2/99					
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KQ	9-27285	1/97	Japan			No					
KQ	9-27264	1/97	Japan			No					
KQ	11-317181	11/99	Japan			No					
KQ	0 865069	3/98	EPO			Abstract					
KQ	10-321167	12/98	Japan			Abstract					
KQ	10-255692	9/98	Japan			Abstract					
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КQ	•	W.P. Dyke et al., "Field Admission", Advances in Electronics and Electron Physics, Vol. 8 (Academic Press, 1956) pp. 89-185									
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE			
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